

<b>Notice of References Cited</b>	Application/Control No. 10/798,722	Applicant(s)/Patent Under Reexamination PICOT ET AL.	
	Examiner Akm Enayet Ullah	Art Unit 2874	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0218870	11-2004	Blauvelt et al.	385/050
	B	US-2003/0081902	05-2003	Blauvelt et al.	385/50
	C	US-6,304,708	10-2001	Fukuyama et al.	385/137
	D	US-2001/0033722	10-2001	Okada et al.	385/94
	E	US-2001/0019648	09-2001	Nobuhara, Hiroyuki	385/84
	F	US-2001/0010742	08-2001	Nakagawa et al.	385/84
	G	US-6,873,770	03-2005	Leung et al.	385/52
	H	US-6,647,184	11-2003	Ukechi et al.	385/47
	I	US-6,567,590	05-2003	Okada et al.	385/49
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.